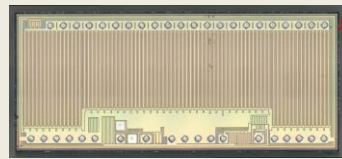


NAVITAS' NV611X SERIES GAN POWER IC STRUCTURE ANALYSIS

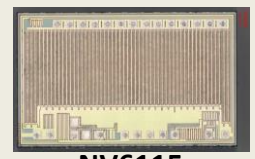
July 2018. LTEC Corporation released a detailed structure analysis report of the NV611X, a GAN Power IC having a 650V switch. NAVITAS is the first GaN manufacturer to introduce a GaN FET and GaN drive circuit on the same die. The NV6115 and NV6117 are the subjects of our structure analysis.



Package



**NV6117
Die (Top metal)**



**NV6115
Die (Top metal)**

Product outline

- $V_{dss}=650V$, NV6117:Rds (ON)=110m Ω (typ.), NV6115:Rds (ON)=160m Ω (typ.)

Device features

- 650V and 30V GaN lateral transistors are used
- The die is manufactured by TSMC (Taiwan Semiconductor Manufacturing Co., Ltd)
- Double superlattice layer is used for the GaN epitaxial layer.

The ninety-page report includes package image, X-ray, plan view analysis, SEM cross section, EDX material analysis and Rds (ON) measurement.

Note:

Since the epi-layer structures of the NV6115 & NV6117 are identical, the analysis data taken of both devices is as listed below.

NV6117: package image, X-ray, plan view analysis, SEM cross section of the 650V transistor, and Rds(ON) measurement.

NV6115: SEM cross section of the 30V transistors, resistors, capacitors, and TEM EDX analysis.

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